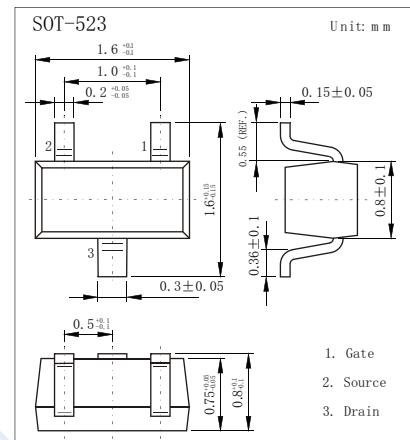
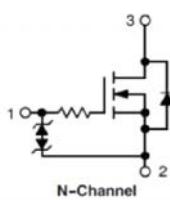


N-Channel MOSFET

2KK5016

■ Features

- $V_{DS} = 20$ V
- $I_D = 238$ mA
- $R_{DS(on)} = 1.5\Omega$ @ $V_{GS}=4.5V$ (Typ.)
- Low Gate Charge for Fast Switching
- ESD Protected Gate

■ Absolute Maximum Ratings ($T_A = 25^\circ C$)

| Parameter | | Symbol | Rating | Unit |
|-----------------------------------|-----------------------------|-----------|------------|--------------|
| Drain-Source Voltage | | V_{DS} | 20 | V |
| | | V_{GS} | ± 10 | |
| Continuous Drain Current (Note 1) | Steady State = $25^\circ C$ | I_D | 238 | mA |
| | $t_P \leqslant 10\mu s$ | I_{DM} | 714 | |
| Power Dissipation (Note 1) | Steady State = $25^\circ C$ | P_D | 300 | W |
| | | R_{QJA} | 416 | $^\circ C/W$ |
| Junction Temperature | | T_J | 150 | $^\circ C$ |
| | | T_{stg} | -55 to 150 | |

Note 1: Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [1 oz] including traces).

N-Channel MOSFET

2KK5016

■ Electrical Characteristics ($T_A = 25^\circ\text{C}$, unless otherwise specified)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|-----------------------------------|---------------------|--|-----|------|-----------|---------------|
| Drain-Source Breakdown Voltage | V_{DSS} | $I_D=100\mu\text{A}, V_{GS}=0\text{V}$ | 20 | | | V |
| Zero Gate Voltage Drain Current | I_{DSs} | $V_{DS}=20\text{V}, V_{GS}=0\text{V}$ | | | 1 | μA |
| Gate-Body Leakage Current | I_{GSs} | $V_{DS}=0\text{V}, V_{GS}=\pm 10\text{V}$ | | | ± 100 | μA |
| Gate Threshold Voltage | $V_{GS(\text{th})}$ | $V_{DS}=3\text{V}, I_D=100\mu\text{A}$ | 0.5 | | 1.5 | V |
| Static Drain-Source On-Resistance | $R_{DS(\text{on})}$ | $V_{GS}=4.5\text{V}, I_D=10\text{mA}$ | | 1.5 | 3.0 | Ω |
| | | $V_{GS}=2.5\text{V}, I_D=10\text{mA}$ | | 2.0 | 3.5 | |
| Forward Transconductance | g_{FS} | $V_{DS}=3\text{V}, I_D=10\text{mA}$ | | 80 | | mS |
| Input Capacitance | C_{iss} | $V_{GS}=0\text{V}, V_{DS}=5\text{V}, f=1\text{MHz}$ | | 11.5 | 20 | pF |
| Output Capacitance | C_{oss} | | | 10 | 15 | |
| Reverse Transfer Capacitance | C_{rss} | | | 3.5 | 6.0 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}, I_D = 10 \text{ mA}, R_G = 10 \Omega$ | | 13 | | ns |
| Turn-On Rise Time | t_r | | | 15 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 98 | | |
| Turn-Off Fall Time | t_f | | | 60 | | |
| Diode Forward Voltage | V_{SD} | $I_{SD}=10\text{mA}, V_{GS}=0\text{V}$ | | 0.66 | 0.80 | V |

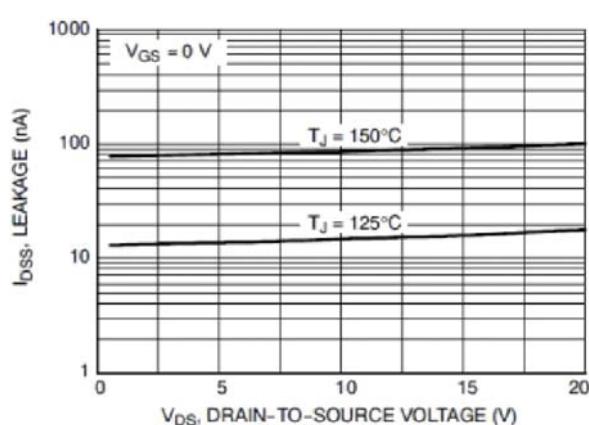
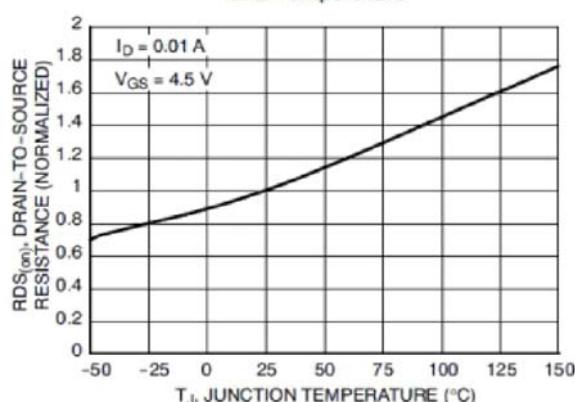
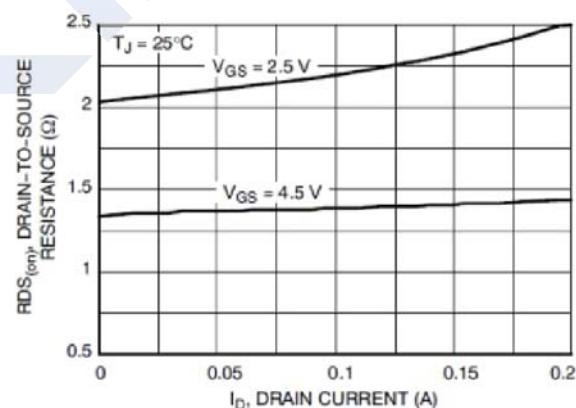
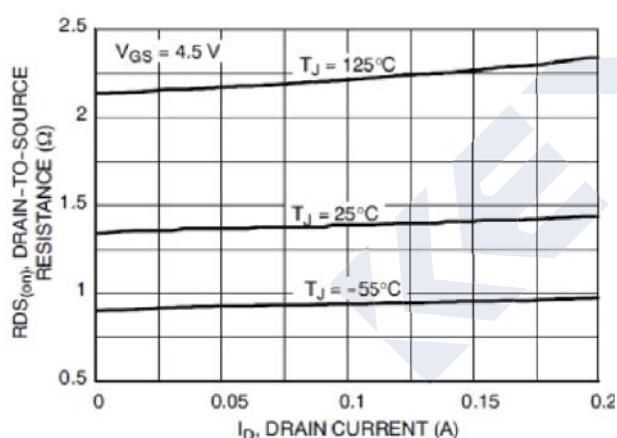
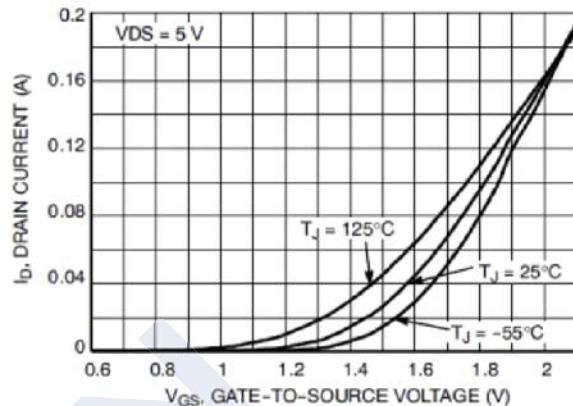
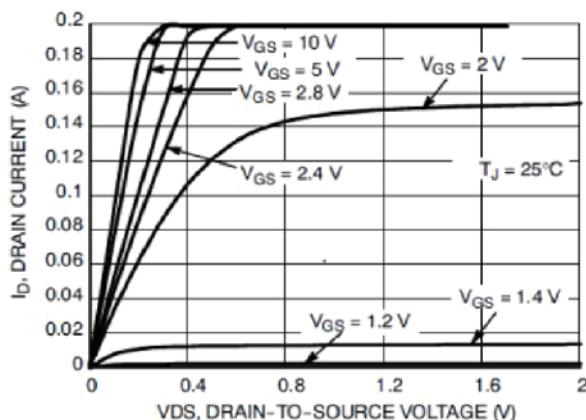
Note 2: Pulse Test: pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

Note 3: Switching characteristics are independent of operating junction temperatures.

N-Channel MOSFET

2KK5016

■ Typical Characteristics



N-Channel MOSFET

2KK5016

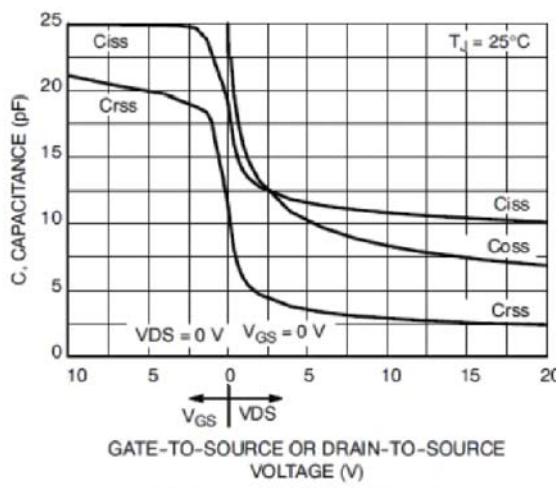


Figure 7. Capacitance Variation

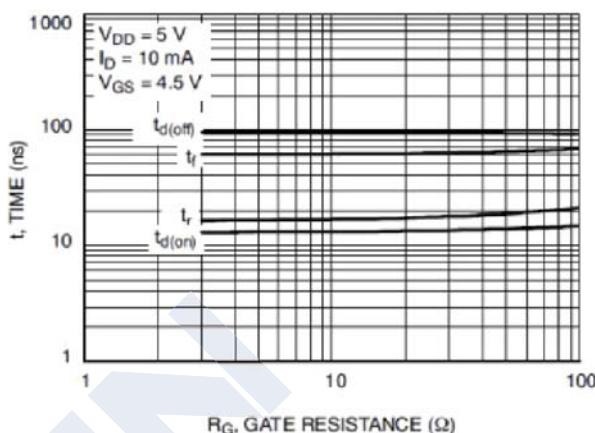


Figure 8. Resistive Switching Time Variation versus Gate Resistance

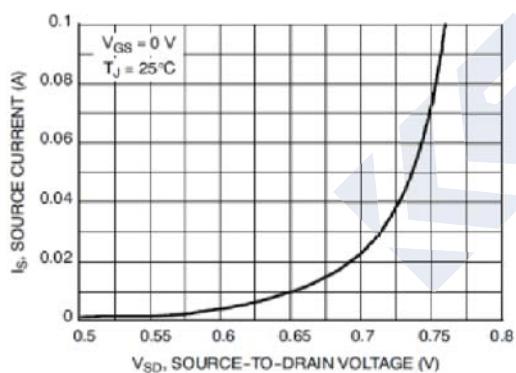


Figure 9. Diode Forward Voltage versus Current